Search Notes



plication/Control No.	Applicant(s)/Patent under
	Reexamination

Aр

10/697,244 ONISHI ET AL.

Examiner Art Unit

RYAN HSU 3714

SEARCHED					
Class	Subclass	Date	Examiner		
463	1,16,20- 22,30-34	7/1/2008	RH		
273	138.1-2	7/1/2008	RH		
273	143R	7/1/2008	RH		
345	4-6	7/1/2008	RH		
	1	1	1		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			1	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
,	DATE	EXMR		
see updated EAST search notes	7/1/2008	RH		